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EIA-535BAAD

EIA DETAIL SPECIFICATION

**Fixed Tantalum Chip Capacitor
Style 1 Protected - Extended
Capacitance Range**

EIA-535BAAD

JANUARY 1991

ELECTRONIC INDUSTRIES ASSOCIATION
ENGINEERING DEPARTMENT

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FIXED TANTALUM CHIP CAPACITOR

STYLE 1 PROTECTED - EXTENDED CAPACITANCE RANGE

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